		Application/Control No.	Applicant(s)/Patent Under Reexamination
Notice of References Cited		10/786,066	HOFMAN ET AL.
		Examiner	Art Unit	Page 1 of 1
		Sajous Wesner	2628	

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-2003/0058475	03-2003	Hofman, Paul Michiel	358/3.01
*	B	US-2004/0223641	11-2004	Koyama et al.	382/162
*	C	US-6,473,521	10-2002	Hino, Yasuhiro	382/164
*	D	US-6,128,407	10-2000	Inoue et al.	382/167
*	E	US-5,729,360	03-1998	Kita et al.	358/500
	F	US-			
	G	US-			
	H	US-			
	I	US-			
	J	US-			
	K	US-			
	L	US-			
	M	US-			

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	O					
	P					
	Q					
	R					
	S					
	T					

NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	Tao et al. "Color image edge detection using cluster analysis", Proceedings of the International Conference on Image Processing, Oct. 26-29, 1997, Vol. 1, p 834-836.
	V	
	W	
	X	

*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)
Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.